

2SB1179, 2SB1179A

Silicon PNP epitaxial planar type darlington

For power amplification and switching
Complementary to 2SD1749, 2SD1749A

■ Features

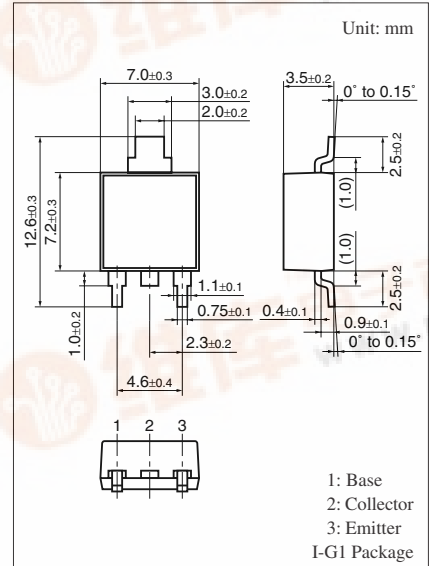
- High forward current transfer ratio h_{FE} which has satisfactory linearity
- High-speed switching
- I type package enabling direct soldering of the radiating fin to the printed circuit board, etc. of small electronic equipment

■ Absolute Maximum Ratings $T_C = 25^\circ C$

Parameter	Symbol	Rating	Unit
Collector-base voltage (Emitter open)	2SB1179	-60	V
	2SB1179A	-80	
Collector-emitter voltage (Base open)	2SB1179	-60	V
	2SB1179A	-80	
Emitter-base voltage (Collector open)	V_{EBO}	-5	V
Collector current	I_C	-4	A
Peak collector current	I_{CP}	-8	A
Collector power dissipation	P_C	15	W
		$T_a = 25^\circ C$	
Junction temperature	T_j	150	$^\circ C$
Storage temperature	T_{stg}	-55 to +150	$^\circ C$

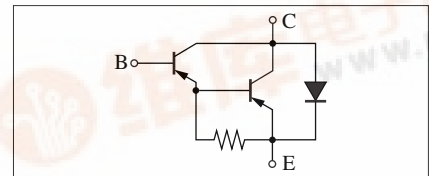
■ Electrical Characteristics $T_C = 25^\circ C \pm 3^\circ C$

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Collector-emitter voltage (Base open)	V_{CEO}	$I_C = -30 \text{ mA}, I_B = 0$	-60			V
			-80			
Base-emitter voltage	V_{BE}	$V_{CE} = -3 \text{ V}, I_C = -3 \text{ A}$			-2.5	V
Collector-base cutoff current (Emitter open)	2SB1179	$V_{CB} = -60 \text{ V}, I_E = 0$			-200	μA
	2SB1179A	$V_{CB} = -80 \text{ V}, I_E = 0$			-200	
Collector-emitter cutoff current (Base open)	I_{CEO}	$V_{CE} = -40 \text{ V}, I_B = 0$			-500	μA
		$V_{CE} = -40 \text{ V}, I_B = 0$			-500	
Emitter-base cutoff current (Collector open)	I_{EBO}	$V_{EB} = -5 \text{ V}, I_C = 0$			-2	mA
Forward current transfer ratio	h_{FE1}	$V_{CE} = -3 \text{ V}, I_C = -0.5 \text{ A}$	1000			—
	h_{FE2}^*	$V_{CE} = -3 \text{ V}, I_C = -3 \text{ A}$	2000		10000	
Collector-emitter saturation voltage	$V_{CE(sat)}$	$I_C = -3 \text{ A}, I_B = -12 \text{ mA}$			-2	V
		$I_C = -5 \text{ A}, I_B = -20 \text{ mA}$			-4	
Transition frequency	f_T	$V_{CE} = -10 \text{ V}, I_C = -0.5 \text{ A}, f = 1 \text{ MHz}$		20		MHz
Turn-on time	t_{on}	$I_C = -3 \text{ A}, I_{B1} = -12 \text{ mA}, I_{B2} = 12 \text{ mA}$		0.3		μs
Storage time	t_{stg}	$V_{CC} = -50 \text{ V}$		2.0		μs
Fall time	t_f			0.5		μs



Note) Self-supported type package is also prepared.

Internal Connection

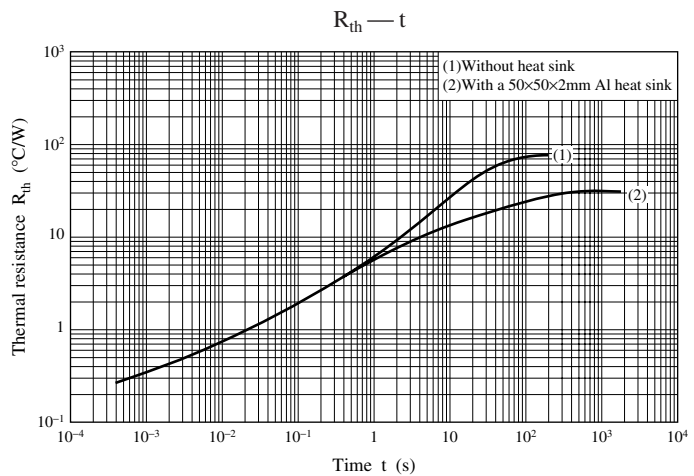
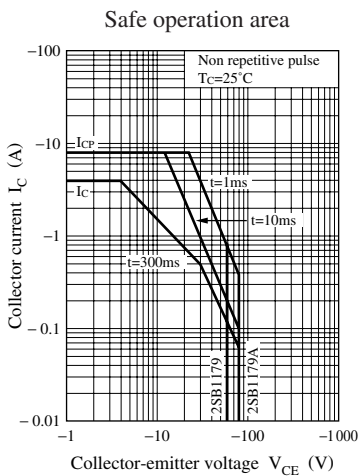
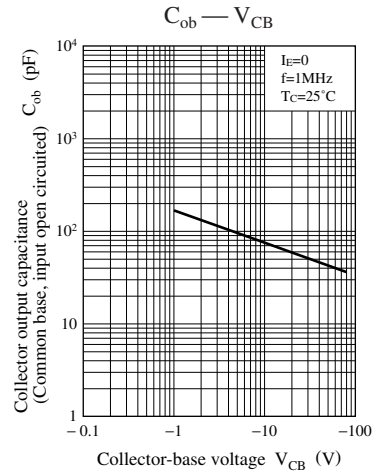
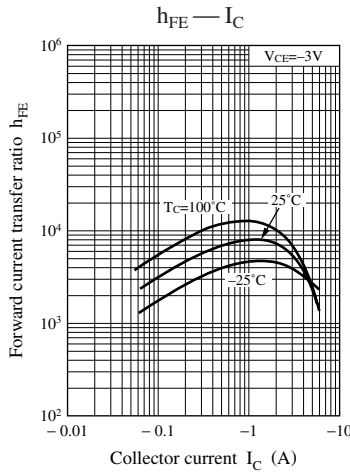
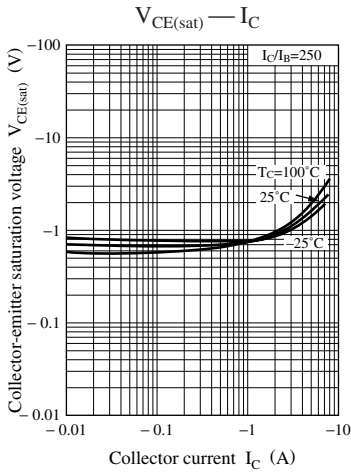
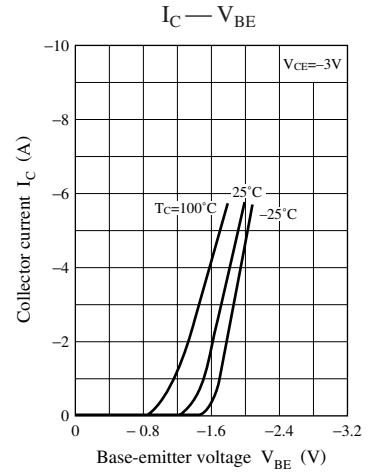
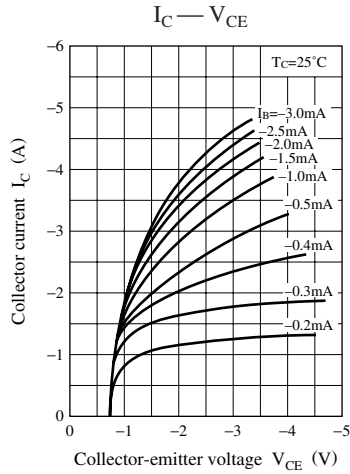
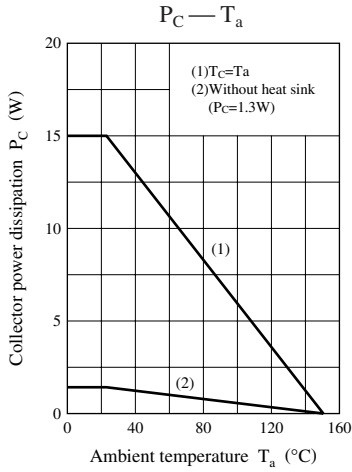


Note) Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

*: Rank classification

Rank	Q	P
h_{FE2}	2000 to 5000	4000 to 10000





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